


<b>Search Notes</b>  	<b>Application/Control No.</b>  10800397	<b>Applicant(s)/Patent Under Reexamination</b>  FLESCH ET AL.
	<b>Examiner</b>  Nano, Sargon N	<b>Art Unit</b>  2157

### SEARCHED

Class	Subclass	Date	Examiner
709	203, 204, 206, 207, 227	11/4/2009	SN
715	706, 756, 771	11/4/2009	SN
709	205, 225, 227, 228	6/5/2010	SN

### SEARCH NOTES

Search Notes	Date	Examiner
Consulted with Primary Yves Dalencourt	11/22/2008	SN
consulted with Primary M. Meki	10/30/2009	SN
Consulted with Primary Hani Kazimi	11/4/2009	SN
Consulted with SPE Trammel	11/4/2009	SN
consulted with SPE Jeff Smith	11/4/2009	SN
EAST search	11/4/2009	SN
Consulted with Simon ke	11/4/2009	SN
Consulted with Primary Lashonda Jacobs	6/3/2010	SN
Consulted with Primary Simon ke art unit 2174	6/3/2010	SN

### INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
709	205, 225	6/5/2010	SN

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